

L Number	Hits	Search Text	DB	Time stamp
1	375	29/848,855,856,858.ccls. and mold\$3	USPAT; JPO; DERWENT	2003/11/07 13:18
2	315	(29/848,855,856,858.ccls. and mold\$3) and (before or after)	USPAT; JPO; DERWENT	2003/11/07 13:18
4	16	((29/848,855,856,858.ccls. and mold\$3) and (before or after)) and @ad<20000327) and sensor	USPAT; JPO; DERWENT	2003/11/07 13:19
3	284	((29/848,855,856,858.ccls. and mold\$3) and (before or after)) and @ad<20000327	USPAT; JPO; DERWENT	2003/11/07 14:27
5	109	(mold with embed\$) with connector	USPAT; JPO; DERWENT	2003/11/07 14:27
6	93	((mold with embed\$) with connector) and @ad<20000327	USPAT; JPO; DERWENT	2003/11/07 14:27
-	5160	29/592.1,622,825,874,876,877.ccls.	USPAT; JPO	2003/11/06 17:14
-	689	29/592.1,622,825,874,876,877.ccls. and (switch\$2 or contactor)	USPAT; JPO	2002/07/30 11:52
-	39	(29/592.1,622,825,874,876,877.ccls. and (switch\$2 or contactor)) and contact and (spring or bias\$3) and spacer	USPAT; JPO	2002/07/30 11:53
-	18457	200/\$.ccls. and (switch\$2 or contactor)	USPAT; JPO	2002/07/30 12:30
-	1105	(200/\$.ccls. and (switch\$2 or contactor)) and contact and (spring or bias\$3) and spacer	USPAT; JPO	2002/07/30 12:30
-	36	((200/\$.ccls. and (switch\$2 or contactor)) and contact and (spring or bias\$3) and spacer) and (contact adj carrier)	USPAT; JPO	2002/07/30 11:57
-	535	200/16a,16b,16c,243,307.ccls. and (switch\$2 or contactor)	USPAT; JPO	2002/07/30 12:46
-	29	(200/16a,16b,16c,243,307.ccls. and (switch\$2 or contactor)) and contact and (spring or bias\$3) and spacer	USPAT; JPO	2002/07/30 12:46
-	1	("4029924").PN.	USPAT; JPO	2002/07/30 12:38
-	15	4029924.URPN.	USPAT	2002/07/30 12:38
-	284	(moving adj contact) and (spring or bias\$3) and spacer	USPAT; JPO	2002/07/30 12:44
-	0	((moving adj contact) and (spring or bias\$3) and spacer) and (light\$3 adj contactor)	USPAT; JPO	2002/07/30 12:44
-	11	light\$3 adj contactor	USPAT; JPO	2002/07/30 12:45
-	348	contactor and contact and (spring or bias\$3) and spacer	USPAT; JPO	2002/07/30 12:46
-	4	200/16a,16b,16c,243,307.ccls. and (contactor and contact and (spring or bias\$3) and spacer)	USPAT; JPO	2002/07/30 12:46
-	2	29/592.1,622,825,874,876,877.ccls. and (contactor and contact and (spring or bias\$3) and spacer)	USPAT; JPO	2002/07/30 12:48
-	5629	hollow same biasing	USPAT; JPO	2003/11/06 17:14
-	2798	hollow same biasing same (inside or within)	USPAT; JPO	2003/11/06 17:15
-	194	(hollow same biasing same (inside or within)) and (biasing same station\$3)	USPAT; JPO	2003/11/06 17:15
-	0	((hollow same biasing same (inside or within)) and (biasing same station\$3)) and contractor	USPAT; JPO	2003/11/06 17:16
-	66	((hollow same biasing same (inside or within)) and (biasing same station\$3)) and switch\$3	USPAT; JPO	2003/11/06 17:16
-	66	((hollow same biasing same (inside or within)) and (biasing same station\$3)) and switch\$3) and @ad<20010629	USPAT; JPO	2003/11/06 17:18
-	5	(stationary adj (biasing or spring)) same hollow	USPAT; JPO	2003/11/06 17:20
-	543	(stationary adj (biasing or spring))	USPAT; JPO	2003/11/06 17:20

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Gutierrez Mazzoti, C.; Herrera Ruiz, G.; Haidegger, G.; Kovacs, G.; Factory 2000, 1992. 'Competitive Performance Through Advanced Technology'. International Conference on (Conf. Publ. No. 359) , 27-29 Jul 1992
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[\[Abstract\]](#) [\[PDF Full-Text \(220 KB\)\]](#) **IEE CNF****2 Sensing system for controlling automatic dyeing or printing process textile**

Okamura, S.; Kimura, Y.; Mohammadnejad, S.; Industry Applications Conference, 1996. Thirty-First IAS Annual Meeting, IAS '96 Conference Record of the 1996 IEEE , Volume: 3 , 6-10 Oct. 1996
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[\[Abstract\]](#) [\[PDF Full-Text \(372 KB\)\]](#) **IEEE CNF****3 Industrial environment proximity switches**

Kjesbu, S.; Communications Engineer , Volume: 1 Issue: 1 , Feb. 2003
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[\[Abstract\]](#) [\[PDF Full-Text \(355 KB\)\]](#) **IEE JNL****4 Energization of large shunt reactors near static VAR compensators at HVDC converters**

Puente, H.R.; Burgess, M.L.; Larsen, E.V.; Elahi, H.;

Power Delivery, IEEE Transactions on , Volume: 4 Issue: 1 , Jan. 1989
Page(s): 629 -636

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